

The RF MOSFET Line

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for W-CDMA base station applications with frequencies from 2110 to 2170 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN - PCS/cellular radio and WLL applications.

- Typical 2-carrier W-CDMA Performance for $V_{DD} = 28$ Volts, $I_{DQ} = 1000$ mA, $f_1 = 2135$ MHz, $f_2 = 2145$ MHz, Channel Bandwidth = 3.84 MHz, Adjacent Channels Measured over 3.84 MHz BW @ $f_1 - 5$ MHz and $f_2 + 5$ MHz, Distortion Products Measured over a 3.84 MHz BW @ $f_1 - 10$ MHz and $f_2 + 10$ MHz, Peak/Avg. = 8.3 dB @ 0.01% Probability on CCDF.
- Output Power — 19 Watts Avg.
- Power Gain — 13.6 dB
- Efficiency — 23%
- IM3 — -37.5 dBc
- ACPR — -41 dBc
- Internally Matched, Controlled Q, for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Capable of Handling 5:1 VSWR, @ 28 Vdc, 2170 MHz, 90 Watts CW Output Power
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Available with Low Gold Plating Thickness on Leads. L Suffix Indicates 40μ " Nominal.
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	65	Vdc
Gate-Source Voltage	V_{GS}	-0.5, +15	Vdc
Total Device Dissipation @ $T_C = 25^\circ C$ Derate above $25^\circ C$	P_D	224 1.28	Watts $W^\circ C$
Storage Temperature Range	T_{stg}	-65 to +150	$^\circ C$
Operating Junction Temperature	T_J	200	$^\circ C$

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.78	$^\circ C/W$

ESD PROTECTION CHARACTERISTICS

Test Conditions	Class
Human Body Model	1 (Minimum)
Machine Model	M3 (Minimum)

(1) Refer to AN1955/D, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.motorola.com/semiconductors/rf>. Select Documentation/Application Notes - AN1955.

NOTE - **CAUTION** - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

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ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
OFF CHARACTERISTICS					
Drain-Source Breakdown Voltage ($V_{GS} = 0 \text{ Vdc}$, $I_D = 100 \mu\text{A}$)	$V_{(BR)DSS}$	65	—	—	Vdc
Zero Gate Voltage Drain Current ($V_{DS} = 28 \text{ Vdc}$, $V_{GS} = 0 \text{ Vdc}$)	I_{DSS}	—	—	10	μA
Gate-Source Leakage Current ($V_{GS} = 5 \text{ Vdc}$, $V_{DS} = 0 \text{ Vdc}$)	I_{GSS}	—	—	1	μA
ON CHARACTERISTICS (DC)					
Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}$, $I_D = 200 \mu\text{A}$)	$V_{GS(\text{th})}$	2	—	4	Vdc
Gate Quiescent Voltage ($V_{DS} = 28 \text{ Vdc}$, $I_D = 1000 \text{ mA}$)	$V_{GS(Q)}$	3	3.9	5	Vdc
Drain-Source On-Voltage ($V_{GS} = 10 \text{ Vdc}$, $I_D = 2 \text{ A}$)	$V_{DS(\text{on})}$	—	0.18	0.21	Vdc
Forward Transconductance ($V_{DS} = 10 \text{ Vdc}$, $I_D = 2 \text{ A}$)	g_{fs}	—	6	—	S
DYNAMIC CHARACTERISTICS (1)					
Reverse Transfer Capacitance ($V_{DS} = 28 \text{ Vdc}$, $V_{GS} = 0$, $f = 1.0 \text{ MHz}$)	C_{rss}	—	3.6	—	pF
FUNCTIONAL TESTS (In Motorola Test Fixture, 50 ohm system) 2-carrier W-CDMA, 3.84 MHz Channel Bandwidth Carriers, ACPR and IM3 measured in 3.84 MHz Bandwidth. Peak/Avg. = 8.3 dB @ 0.01% Probability on CCDF.					
Common-Source Amplifier Power Gain ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 19 \text{ W Avg.}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2112.5 \text{ MHz}$, $f_2 = 2122.5 \text{ MHz}$ and $f_1 = 2157.5 \text{ MHz}$, $f_2 = 2167.5 \text{ MHz}$)	G_{ps}	12	13.6	—	dB
Drain Efficiency ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 19 \text{ W Avg.}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2112.5 \text{ MHz}$, $f_2 = 2122.5 \text{ MHz}$ and $f_1 = 2157.5 \text{ MHz}$, $f_2 = 2167.5 \text{ MHz}$)	η	20	23	—	%
Third Order Intermodulation Distortion ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 19 \text{ W Avg.}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2112.5 \text{ MHz}$, $f_2 = 2122.5 \text{ MHz}$ and $f_1 = 2157.5 \text{ MHz}$, $f_2 = 2167.5 \text{ MHz}$; IM3 measured over 3.84 MHz BW at $f_1 - 10 \text{ MHz}$ and $f_2 + 10 \text{ MHz}$ referenced to carrier channel power.)	IM3	—	-37.5	-35	dBc
Adjacent Channel Power Ratio ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 19 \text{ W Avg.}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2112.5 \text{ MHz}$, $f_2 = 2122.5 \text{ MHz}$ and $f_1 = 2157.5 \text{ MHz}$, $f_2 = 2167.5 \text{ MHz}$; ACPR measured over 3.84 MHz at $f_1 - 5 \text{ MHz}$ and $f_2 + 5 \text{ MHz}$.)	ACPR	—	-41	-38	dBc
Input Return Loss ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 19 \text{ W Avg.}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2112.5 \text{ MHz}$, $f_2 = 2122.5 \text{ MHz}$ and $f_1 = 2157.5 \text{ MHz}$, $f_2 = 2167.5 \text{ MHz}$)	IRL	—	-12	-9	dB
Output Mismatch Stress ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 90 \text{ W CW}$, $I_{DQ} = 1000 \text{ mA}$, $f = 2170 \text{ MHz}$ VSWR = 5:1, All Phase Angles at Frequency of Tests)	Ψ	No Degradation In Output Power Before and After Test			

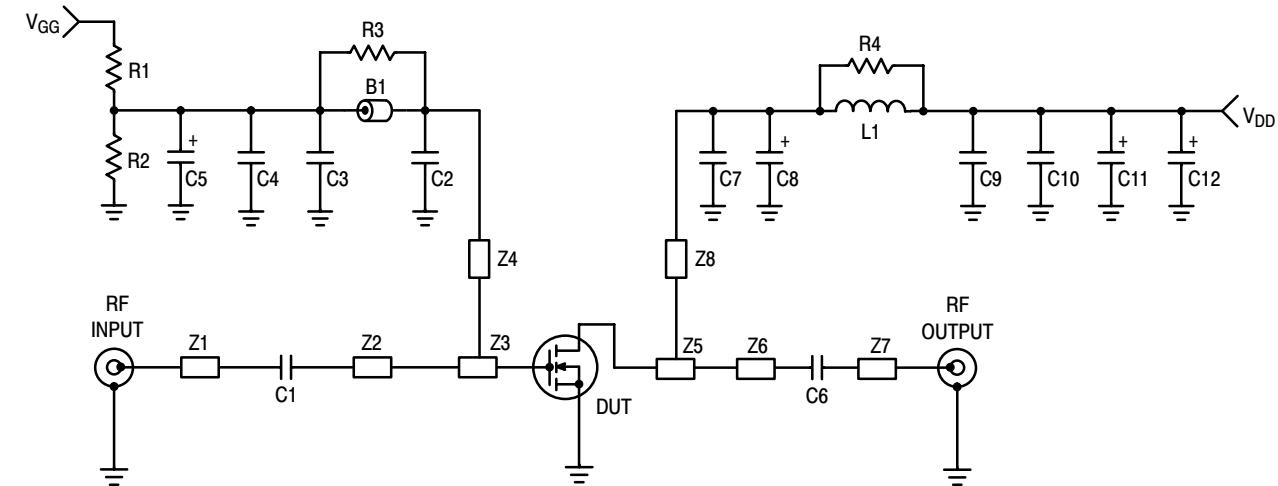
(1) Part is internally matched both on input and output.

(continued)

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ELECTRICAL CHARACTERISTICS — continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
FUNCTIONAL TESTS (In Motorola Test Fixture, 50 ohm system) (continued)					
Two-Tone Common-Source Amplifier Power Gain ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 90 \text{ W PEP}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2110 \text{ MHz}$, $f_2 = 2120 \text{ MHz}$ and $f_1 = 2160 \text{ MHz}$, $f_2 = 2170 \text{ MHz}$)	G_{ps}	—	13.6	—	dB
Two-Tone Drain Efficiency ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 90 \text{ W PEP}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2110 \text{ MHz}$, $f_2 = 2120 \text{ MHz}$ and $f_1 = 2160 \text{ MHz}$, $f_2 = 2170 \text{ MHz}$)	η	—	36	—	%
Two-Tone Intermodulation Distortion ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 90 \text{ W PEP}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2110 \text{ MHz}$, $f_2 = 2120 \text{ MHz}$ and $f_1 = 2160 \text{ MHz}$, $f_2 = 2170 \text{ MHz}$)	IMD	—	-31	—	dBc
Input Return Loss ($V_{DD} = 28 \text{ Vdc}$, $P_{out} = 90 \text{ W PEP}$, $I_{DQ} = 1000 \text{ mA}$, $f_1 = 2110 \text{ MHz}$, $f_2 = 2120 \text{ MHz}$ and $f_1 = 2160 \text{ MHz}$, $f_2 = 2170 \text{ MHz}$)	IRL	—	-12	—	dB
P_{out} , 1 dB Compression Point ($V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 1000 \text{ mA}$, $f = 2170 \text{ MHz}$)	P1dB	—	100	—	W



Z1 0.750" x 0.084" Microstrip
 Z2 1.015" x 0.084" Microstrip
 Z3 0.480" x 0.800" Microstrip
 Z4 0.750" x 0.050" Microstrip
 Z5 0.610" x 0.800" Microstrip
 Z6 0.885" x 0.084" Microstrip
 Z7 0.720" x 0.084" Microstrip
 Z8 0.800" x 0.070" Microstrip

Board 0.030" Glass Teflon®,
 Keene GX-0300-55-22, $\epsilon_r = 2.55$
 PCB Etched Circuit Boards
 MRF21085 Rev. 3, CMR

Figure 1. MRF21085 Test Circuit Schematic

Table 1. MRF21085 Test Circuit Component Designations and Values

Designators	Description
B1	Short Ferrite Bead, Fair Rite, #2743019447
C1, C6	43 pF Chip Capacitors, ATC #100B430JCA500X
C2	10 pF Chip Capacitor, ATC #100B100JCA500X
C3, C9	1000 pF Chip Capacitors, ATC #100B102JCA500X
C4, C10	0.1 μ F Chip Capacitors, Kemet #CDR33BX104AKWS
C5	1.0 μ F Tantalum Chip Capacitor, Kemet #T491C105M050
C7	2.7 pF Chip Capacitor, ATC #100B2R7JCA500X
C8	10 μ F Tantalum Chip Capacitor, Kemet #T495X106K035AS4394
C11, C12	22 μ F Tantalum Chip Capacitors, Kemet #T491X226K035AS4394
L1	1 Turn, #20 AWG, 0.100" ID, Motorola
N1, N2	Type N Flange Mounts, Omni Spectra #3052-1648-10
R1	1.0 k Ω , 1/8 W Chip Resistor
R2	180 k Ω , 1/8 W Chip Resistor
R3, R4	10 Ω , 1/8 W Chip Resistors

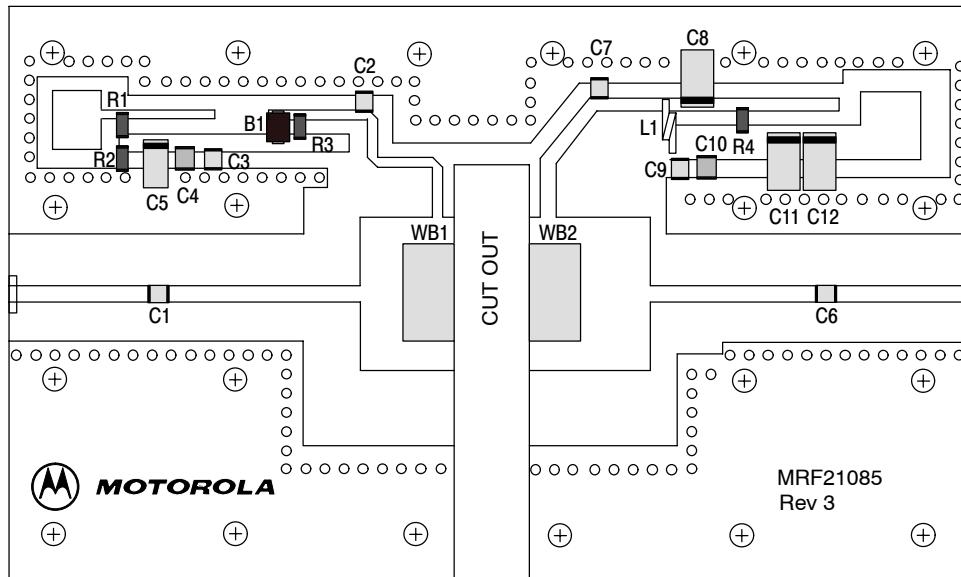


Figure 2. MRF21085 Test Circuit Component Layout

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TYPICAL CHARACTERISTICS

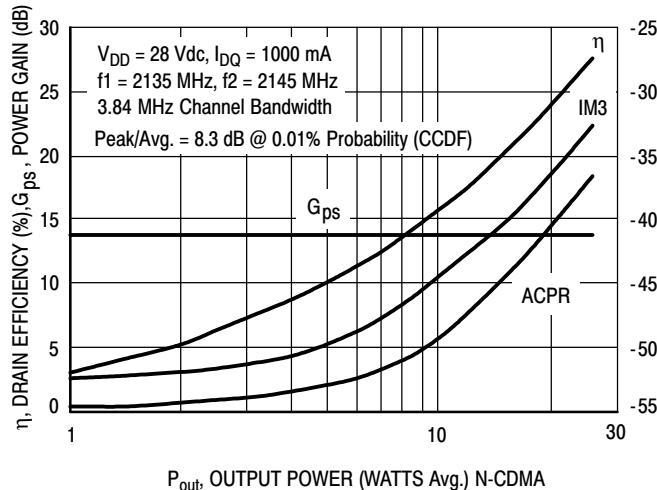


Figure 3. 2-Carrier W-CDMA ACPR, IM3, Power Gain and Drain Efficiency versus Output Power

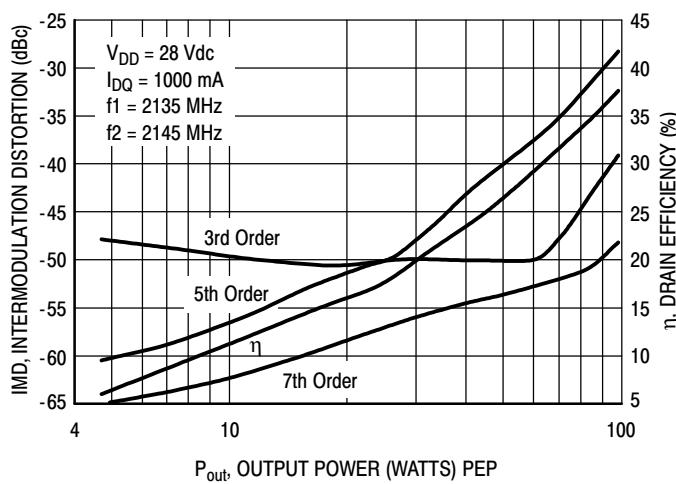


Figure 4. Intermodulation Distortion Products versus Output Power

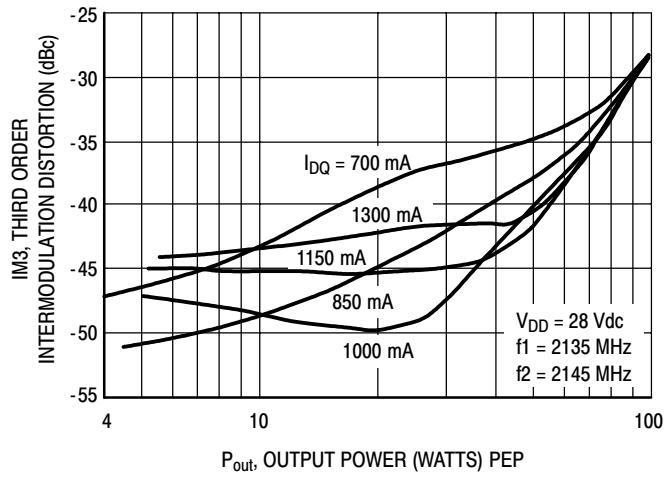


Figure 5. Third Order Intermodulation Distortion versus Output Power

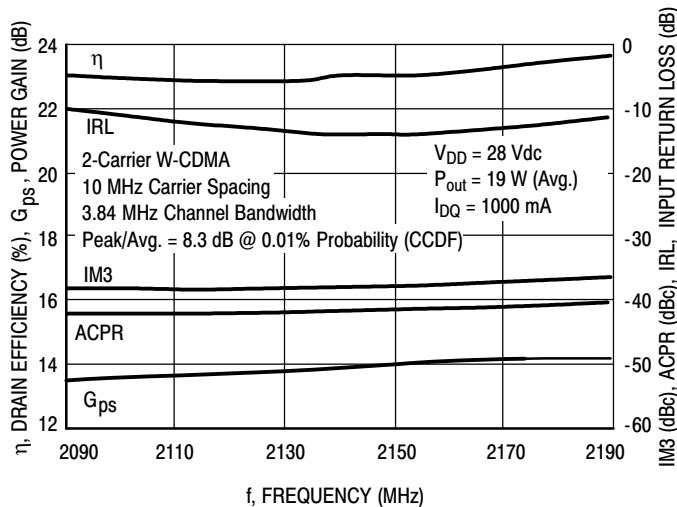


Figure 6. 2-Carrier W-CDMA Broadband Performance

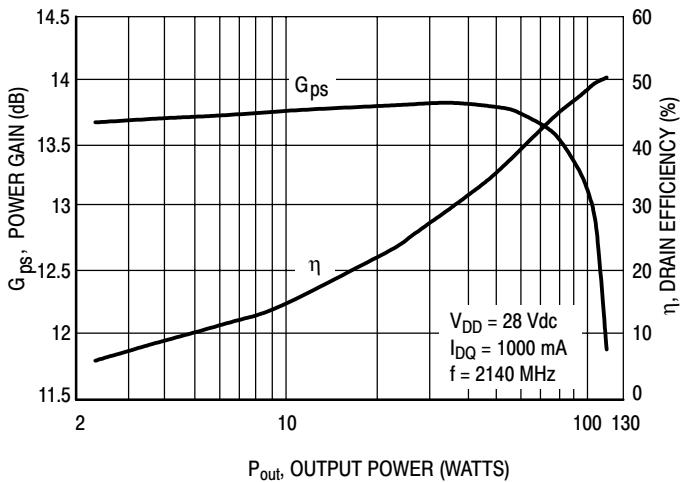


Figure 7. CW Performance

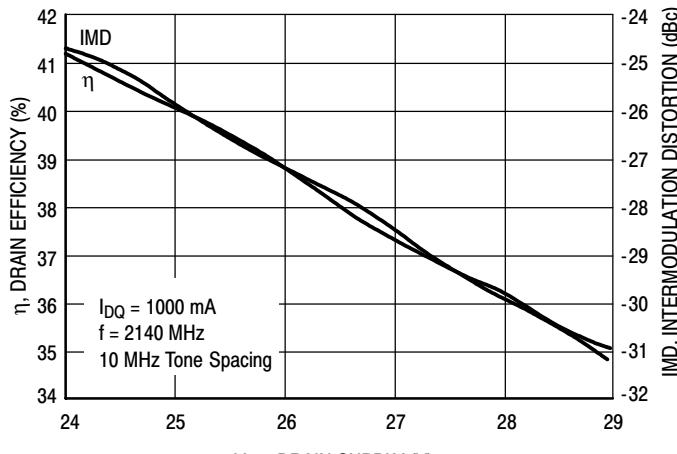
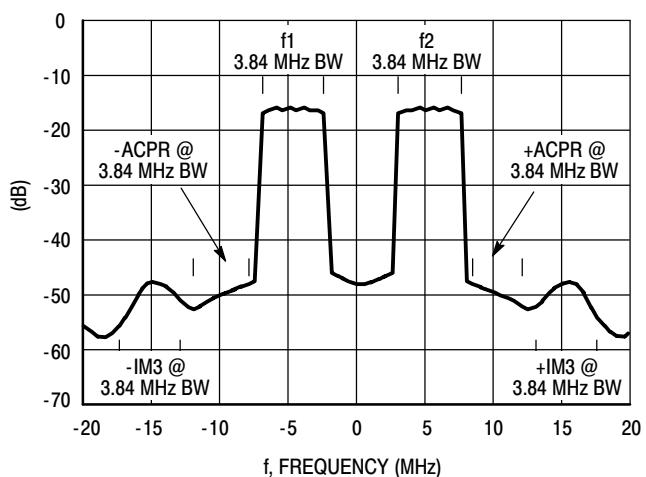
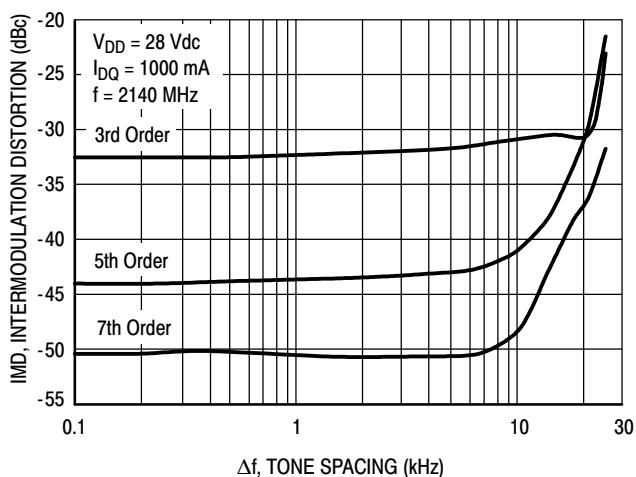
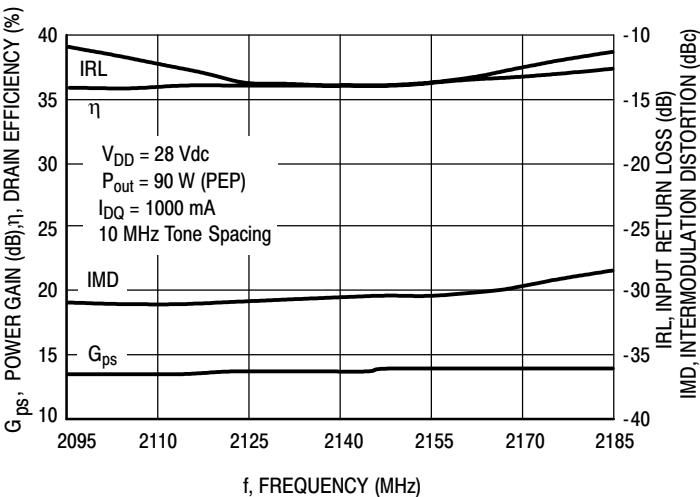
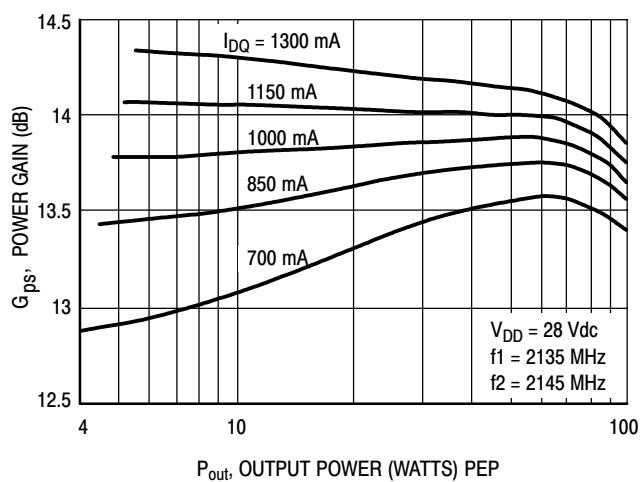
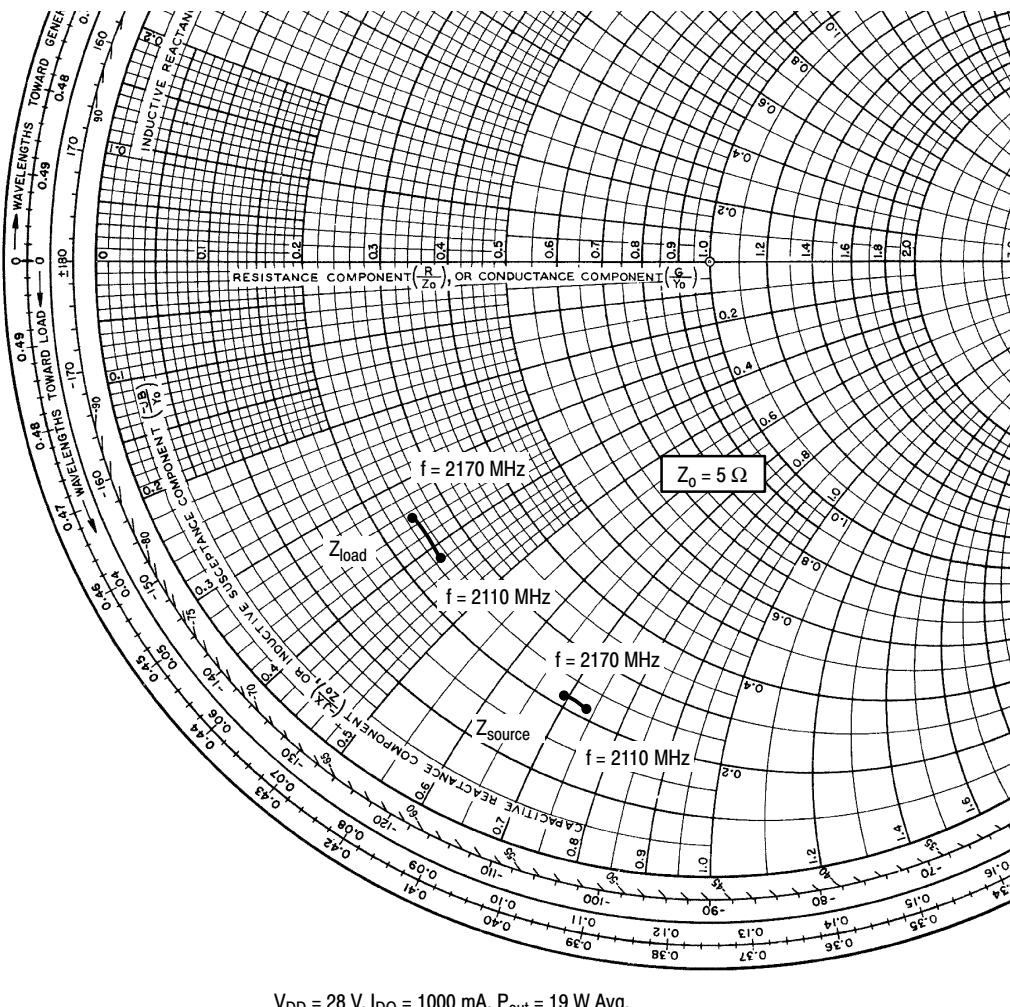


Figure 8. Two-Tone Intermodulation Distortion and Drain Efficiency versus Drain Supply

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TYPICAL CHARACTERISTICS





$V_{DD} = 28$ V, $I_{DQ} = 1000$ mA, $P_{out} = 19$ W Avg.

f MHz	Z_{source} Ω	Z_{load} Ω
2110	$1.10 - j3.71$	$1.23 - j2.10$
2140	$1.11 - j3.57$	$1.26 - j1.92$
2170	$1.12 - j3.40$	$1.25 - j1.76$

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

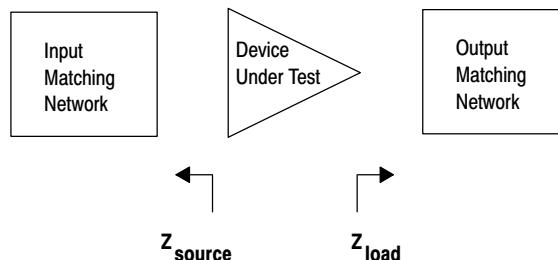


Figure 13. Series Equivalent Input and Output Impedance

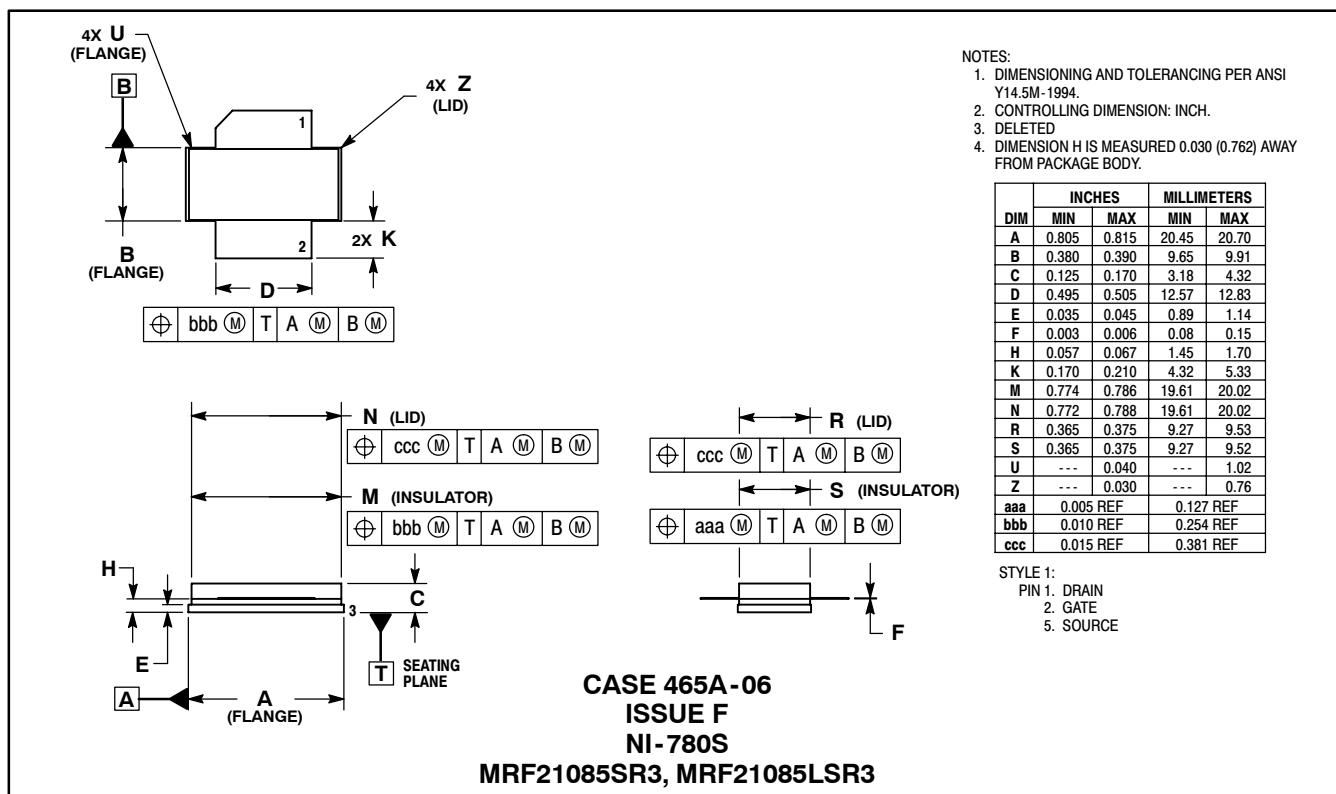
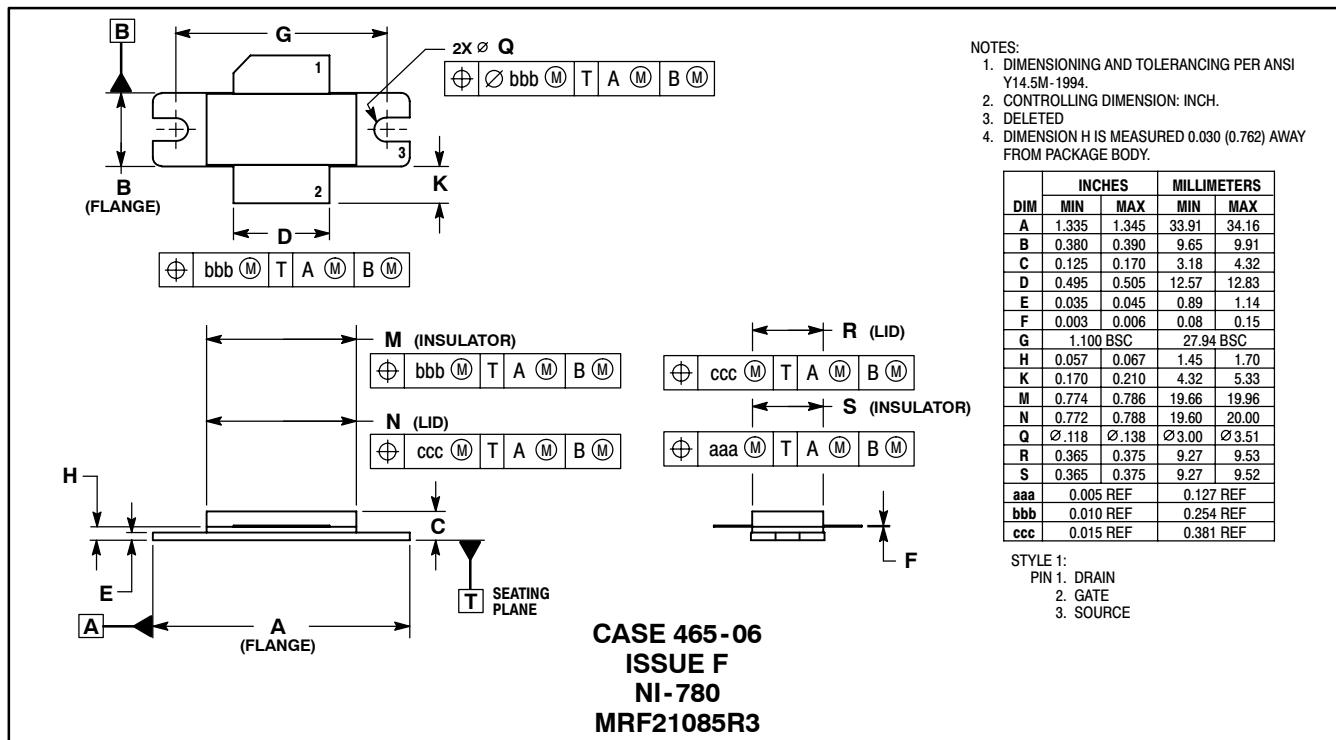
NOTES

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PACKAGE DIMENSIONS

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